

September 2001 Revised February 2002

74ALVCH16244 Low Voltage 16-Bit Buffer/Line Driver with Bushold

General Description

The ALVCH16244 contains sixteen non-inverting buffers with 3-STATE outputs to be employed as a memory and address driver, clock driver, or bus oriented transmitter/ receiver. The device is nibble (4-bit) controlled. Each nibble has separate 3-STATE control inputs which can be shorted together for full 16-bit operation.

The ALVCH16244 data inputs include active bushold circuitry, eliminating the need for external pull-up resistors to hold unused or floating data inputs at a valid logic level.

The 74ALVCH16244 is designed for low voltage (1.65V to 3.6V) V_{CC} applications with output capability up to 3.6V.

The 74ALVCH16244 is fabricated with an advanced CMOS technology to achieve high speed operation while maintaining low CMOS power dissipation.

Features

- \blacksquare 1.65V to 3.6V $\rm V_{CC}$ supply operation
- 3.6V tolerant control inputs and outputs
- Bushold on data inputs eliminating the need for external pull-up/pull-down resistors
- t_{PD}

3 ns max for 3.0V to 3.6V V_{CC} 3.7 ns max for 2.3V to 2.7V V_{CC}

6.0 ns max for 1.65V to 1.95V V_{CC}

- Uses patented noise/EMI reduction circuitry
- Latch-up conforms to JEDEC JED78
- ESD performance:

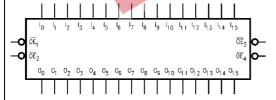
Human body model > 2000V Machine model > 200V

Ordering Code:

Order Number	Package Number		77	Package Description
74ALVCH16244T	MTD48	48-Lea	d Thin Shrink	Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Pin Descriptions

Pin Names	Description					
OE n	Output Enable Input (Active LOW)					
I ₀ –I ₁₅	Bushold Inputs					
O ₀ -O ₁₅	Outputs					

Connection Diagram



Truth Tables

Inp	outs	Outputs
OE ₁	I ₀ –I ₃	O ₀ -O ₃
L	L	L
L	Н	Н
Н	X	Z

Inp	outs	Outputs		
OE ₃	I ₈ -I ₁₁	O ₈ -O ₁₁		
L	L	L		
L	Н	Н		
Н	X	Z		

Inp	outs	Outputs		
OE ₂	I ₄ -I ₇	O ₄ -O ₇		
L	5 JOL /**	L		
_ L XL	H	Н		
71	X	Z		

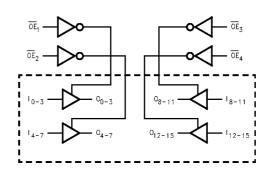
In	outs	Outputs		
OE ₄	I ₁₂ -I ₁₅	O ₁₂ -O ₁₅		
L	L	L		
L	Н	Н		
Н	Х	Z		

- H = HIGH Voltage Level
- L = LOW Voltage Level
- X = Immaterial (HIGH or LOW, inputs may not float) Z = High Impedance

Functional Description

The 74ALVCH16244 contains sixteen non-inverting buffers with 3-STATE outputs. The device is nibble (4 bits) controlled with each nibble functioning identically, but independent of each other. The control pins may be shorted together to obtain full 16-bit operation. The 3-STATE out $\underline{\text{puts}}$ are controlled by an Output Enable $(\overline{\text{OE}}_n)$ input. When $\overline{\text{OE}}_n$ is LOW, the outputs are in the 2-state mode. When $\overline{\text{OE}}_{\text{n}}$ is HIGH, the standard outputs are in the high impedance mode but this does not interfere with entering new data into the inputs.

Logic Diagram



Absolute Maximum Ratings(Note 1)

 $\begin{array}{lll} \mbox{Supply Voltage (V$_{CC}$)} & -0.5\mbox{V to } +4.6\mbox{V} \\ \mbox{DC Input Voltage (V$_{I}$)} & -0.5\mbox{V to } 4.6\mbox{V} \\ \end{array}$

Output Voltage (V $_{\rm O}$) (Note 2) $-0.5 \mbox{V}$ to V $_{\rm CC}$ +0.5 \mathbf{V}

DC Input Diode Current (I_{IK})

 $V_1 < 0V$ –50 mA

DC Output Diode Current (I_{OK})

 $V_O < 0V$ –50 mA

DC Output Source/Sink Current

 (I_{OH}/I_{OL}) ±50 mA

DC V_{CC} or GND Current per

Supply Pin (I $_{\rm CC}$ or GND) ± 100 mA Storage Temperature Range (T $_{\rm STG}$) $-65^{\circ}{\rm C}$ to $+150^{\circ}{\rm C}$

Recommended Operating Conditions (Note 3)

Power Supply

 $\begin{array}{ccc} \text{Operating} & \text{1.65V to 3.6V} \\ \text{Input Voltage (V_I)} & \text{0V to V}_{CC} \\ \text{Output Voltage (V}_{O}) & \text{0V to V}_{CC} \\ \end{array}$

Free Air Operating Temperature (T_A) $-40^{\circ}C$ to $+85^{\circ}C$

Minimum Input Edge Rate ($\Delta t/\Delta V$)

 $V_{IN} = 0.8V$ to 2.0V, $V_{CC} = 3.0V$ 10 ns/V

Note 1: The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the Absolute Maximum Ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 2: I_O Absolute Maximum Rating must be observed, limited to 4.6V.

Note 3: Floating or unused control inputs must be held HIGH or LOW.

DC Electrical Characteristics

Symbol	Parameter	Conditions	V _{CC}	Min	Max	Units
V _{IH}	HIGH Level Input Voltage	36.35	1.65 - 1.95 2.3 - 2.7 2.7 - 3.6	0.65 x V _{CC} 1.7 2.0		V
V _{IL}	LOW Level Input Voltage	0.0	1.65 - 1.95 2.3 - 2.7 2.7 - 3.6		0.35 x V _{CC} 0.7 0.8	V
V _{OH}	HIGH Level Output Voltage	I_{OH} = -100 μ A I_{OH} = -4 mA I_{OH} = -6 mA	1.65 - 3.6 1.65 2.3	V _{CC} - 0.2 1.2 2.0		
		I _{OH} = -12 mA	2.3 2.7 3.0	1.7 2.2 2.4		V
V _{OL}	LOW Level Output Voltage	$\begin{split} I_{OH} = -24 \text{ mA} \\ I_{OL} = 100 \mu\text{A} \\ I_{OL} = 4 \text{ mA} \\ I_{OL} = 6 \text{ mA} \end{split}$	3.0 1.65 - 3.6 1.65 2.3	2	0.2 0.45 0.4	V
		I_{OL} = 12 mA I_{OL} = 24 mA	2.3 2.7 3.0		0.7 0.4 0.55	v
I _I	Input Leakage Current Bushold Input Minimum Drive Hold Current	$\begin{aligned} 0 &\leq V_{I} \leq 3.6V \\ V_{IN} &= 0.58V \\ V_{IN} &= 1.07V \end{aligned}$	3.6 1.65 1.65	25 -25	±5.0	μА
		$egin{array}{l} V_{IN} = 0.7V \\ V_{IN} = 1.7V \\ \hline V_{IN} = 0.8V \\ V_{IN} = 2.0V \\ \hline \end{array}$	2.3 2.3 3.0 3.0	45 -45 75 -75		μА
I _{OZ}	3-STATE Output Leakage	$0 < V_O \le 3.6V$ $0 \le V_O \le 3.6V$	3.6		±500 ±10	μА
I _{CC}	Quiescent Supply Current Increase in I _{CC} per Input	$V_I = V_{CC}$ or GND, $I_O = 0$ $V_{IH} = V_{CC} - 0.6V$	3.6 3 - 3.6		40 750	μΑ

AC Electrical Characteristics

	Parameter	$T_A = -40^{\circ}$ C to $+85^{\circ}$ C, $R_L = 500\Omega$								
Symbol		C _L = 50 pF			C _L = 30 pF				Units	
Cymbol		$V_{CC} = 3.3V \pm 0.3V$		V _{CC} = 2.7V		$V_{CC} = 2.5V \pm 0.2V$		$V_{CC} = 1.8V \pm 0.15V$		Jiins
		Min	Max	Min	Max	Min	Max	Min	Max	
t _{PHL} , t _{PLH}	Propagation Delay	1.0	3		3.6	1.0	3.7	1.5	6.0	ns
t _{PZL} , t _{PZH}	Output Enable Time	1.0	4.4		5.4	1.0	5.7	1.5	8.2	ns
t _{PLZ} , t _{PHZ}	Output Disable Time	1.0	4.1		4.6	1.0	5.2	1.5	6.8	ns

Capacitance

Symbol	Parameter		Conditions	$T_A =$	Units	
Symbol			Conditions	v _{cc}	Typical	Oillis
C _{IN}	Input Capacitance	Control	$V_I = 0V$ or V_{CC}	3.3	3	pF
		Data	$V_I = 0V$ or V_{CC}	3.3	6	þг
C _{OUT}	Output Capacitance	•	$V_I = 0V$ or V_{CC}	3.3	7	pF
C _{PD}	Power Dissipation Capacitance	Outputs Enabled	f = 10 MHz, C _L = 50 pF	3.3	19	
			48	2.5	16	
		Outputs Disabled	f = 10 MHz, C _L = 50 pF	3.3	5	pF
			44	2.5	4	
		2/1/	is com.			

AC Loading and Waveforms

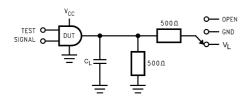


TABLE 1. Values for Figure 1

TEST	SWITCH
t _{PLH} , t _{PHL}	Open
t _{PZL} , t _{PLZ}	V _L
t _{PZH} , t _{PHZ}	GND

FIGURE 1. AC Test Circuit

TABLE 2. Variable Matrix (Input Characteristics: $f=1 MHz; \ t_r=t_f=2 ns; \ Z_0=50 \Omega)$

Symbol	V _{CC}							
Cymbol	3.3V ± 0.3V 2.7V		2.5V ± 0.2V	1.8V ± 0.15V				
V _{mi}	1.5V	1.5V	V _{CC} /2	V _{CC} /2				
V _{mo}	1.5V	1.5V	V _{CC} /2	V _{CC} /2				
V _X	V _{OL} + 0.3V	V _{OL} + 0.3V	V _{OL} + 0.15V	V _{OL} + 0.15V				
V_{Y}	V _{OH} – 0.3V	V _{OH} – 0.3V	V _{OH} – 0.15V	V _{OH} – 0.15V				
V_{L}	6V	6V	V _{CC} *2	V _{CC} *2				

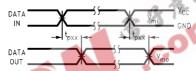


FIGURE 2. Waveform for Inverting and Non-Inverting Functions

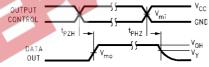


FIGURE 3. 3-STATE Output High Enable and Disable Times for Low Voltage Logic

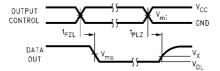
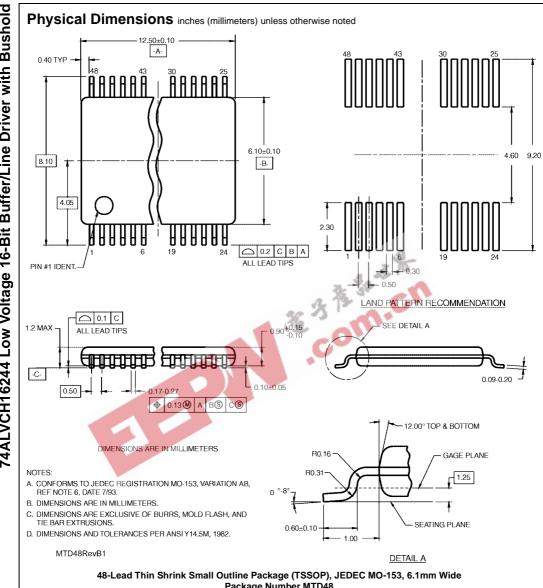


FIGURE 4. 3-STATE Output Low Enable and Disable Times for Low Voltage Logic



Package Number MTD48

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